

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09/940,757	WEI ET AL.
	Examiner	Art Unit
	Minh Trinh	3729
		Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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